

Notice of References Cited	Application/Control No. 09/784,051		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6275404 B1	08-2001	Shichijyo et al.	363/145
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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